

Search Notes

Application/Control No.

10/501,802

Examiner

David E. Bochna

Applicant(s)/Patent under
Reexamination

SMAHL, JARMO

Art Unit

3679

SEARCHED

Class	Subclass	Date	Examiner
285	47	8/19/2006	DB
	50		
	55		
	222.4		
	133.5		
	133.11		
	179		
	61		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR